## Notice of References Cited Application/Control No. 10/606,699 Examiner Yaima Campos Applicant(s)/Patent Under Reexamination MEIRI ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0116404	08-2002	Cha et al.	707/202
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	Е	US-			
	F	US-			
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